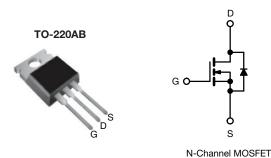




### **Power MOSFET**



PRODUCT SUMMAI	RY	
V <sub>DS</sub> (V)	20	00
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V	1.5
Q <sub>g</sub> max. (nC)	8.	.2
Q <sub>gs</sub> (nC)	1.	.8
Q <sub>gd</sub> (nC)	4.	.5
Configuration	Sin	gle

#### **FEATURES**

- Dynamic dV/dt rating
- Repetitive avalanche rated
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see <a href="https://www.vishay.com/doc?99912"><u>www.vishay.com/doc?99912</u></a>



#### Note

\* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

#### **DESCRIPTION**

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRF610PbF
Lead (Pb)-free and halogen-free	IRF610PbF-BE3

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub>	= 25 °C, unl	ess otherwis	se noted)		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-source voltage			V <sub>DS</sub>	200	V
Gate-source voltage V <sub>GS</sub> ±		± 20	v		
Continuous drain current	\/ at 10.\/	$T_{\rm C} = 25  ^{\circ}{\rm C}$ $T_{\rm C} = 100  ^{\circ}{\rm C}$		3.3	
Continuous drain current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	2.1	A
Pulsed drain current <sup>a</sup>			I <sub>DM</sub>	10	
Linear derating factor				0.29	W/°C
Single pulse avalanche energy b			E <sub>AS</sub>	64	mJ
Repetitive avalanche current a			I <sub>AR</sub>	3.3	А
Repetitive avalanche energy <sup>a</sup>			E <sub>AR</sub>	3.6	mJ
Maximum power dissipation $T_C = 25  ^{\circ}C$			$P_{D}$	36	W
Peak diode recovery dV/dt <sup>c</sup>			dV/dt	5.0	V/ns
Operating junction and storage temperature range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
Soldering recommendations (peak temperature) d	For	10 s		300	
Manustina tagana	6-32 or M3 screw			10	lbf ⋅ in
Mounting torque	0-32 Of 1	NIO SCIEW		1.1	N⋅m

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b.  $V_{DD}$  = 50 V, starting  $T_J$  = 25 °C, L = 8.8 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 3.3 A (see fig. 12)
- c.  $I_{SD} \le 3.3$  A,  $dI/dt \le 70$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C
- d. 1.6 mm from case

# Vishay Siliconix

THERMAL RESISTANCE RAT	INGS			
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum junction-to-ambient	R <sub>thJA</sub>	-	62	
Case-to-sink, flat, greased surface	R <sub>thCS</sub>	0.50	-	°C/W
Maximum junction-to-case (drain)	R <sub>thJC</sub>	-	3.5	

PARAMETER	SYMBOL	TEST	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static					•	•	
Drain-source breakdown voltage	$V_{DS}$	$V_{GS} = 0$	) V, I <sub>D</sub> = 250 μA	200	-	-	V
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I <sub>D</sub> = 1 mA	-	0.30	-	V/°C
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	' <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-source leakage	I <sub>GSS</sub>	V <sub>G</sub>	<sub>iS</sub> = ± 20 V	-	-	± 100	nA
		$V_{DS} = 2$	V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V		-	25	
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> = 160 V, V	/ <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 2.0 A <sup>b</sup>	-	-	1.5	Ω
Forward transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 5	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 2.0 A <sup>b</sup>		-	-	S
Dynamic							
Input capacitance	C <sub>iss</sub>	$V_{GS} = 0 V$ ,		-	140	-	pF
Output capacitance	C <sub>oss</sub>	V <sub>I</sub>	$V_{DS} = 0 V$ , $V_{DS} = 25 V$ ,		53	-	
Reverse transfer capacitance	C <sub>rss</sub>	f = 1.0	MHz, see fig. 5	-	15	-	
Total gate charge	Qg		I <sub>D</sub> = 3.3 A, V <sub>DS</sub> = 160 V, see fig. 6 and 13 <sup>b</sup>	-	-	8.2	nC
Gate-source charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V		-	-	1.8	
Gate-drain charge	$Q_{gd}$		See lig. 6 and 16	-	-	4.5	
Turn-on delay time	t <sub>d(on)</sub>			-	8.2	-	
Rise time	t <sub>r</sub>	$V_{DD}$ = 100 V, $I_{D}$ = 3.3 A, $R_{g}$ = 24 $\Omega$ , $R_{D}$ = 30 $\Omega$ , see fig. 10 b		-	17	-	ns
Turn-off delay time	t <sub>d(off)</sub>			-	14	-	
Fall time	t <sub>f</sub>			-	8.9	-	
Gate input resistance	Rg	f = 1 MHz, open drain		2.3	-	10.2	Ω
Internal drain inductance	L <sub>D</sub>	6 mm (0.25") 1	Between lead, 6 mm (0.25") from		4.5	-	ml I
Internal source inductance	L <sub>S</sub>	package and center of die contact		-	7.5	-	nH
Drain-Source Body Diode Characteristic	es	<u> </u>					
Continuous source-drain diode current	I <sub>S</sub>	showing th	MOSFET symbol showing the		-	3.3	A
Pulsed diode forward current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	10	
Body diode voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>5</sub>	$T_J = 25  ^{\circ}\text{C},  I_S = 3.3  \text{A},  V_{GS} = 0  \text{V}^{ \text{b}}$		-	2.0	V
Body diode reverse recovery time	t <sub>rr</sub>	T 05 00 1			150	310	ns
Body diode reverse recovery charge	Q <sub>rr</sub>	$T_J = 25  ^{\circ}\text{C}, I_F = 3.3  \text{A}, dI/dt = 100  \text{A/}\mu\text{s}^{\text{b}}$		-	0.60	1.4	μC
Forward turn-on time	t <sub>on</sub>	Intrinsic turn	-on time is negligible (turn	on is do	minated b	ov Ls and	L <sub>D</sub> )

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

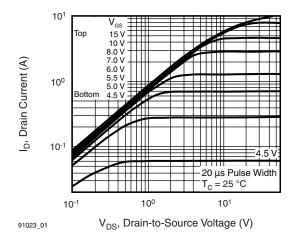


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

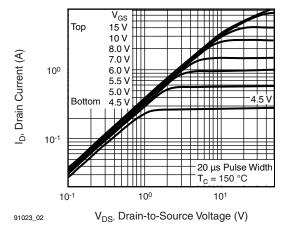


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C

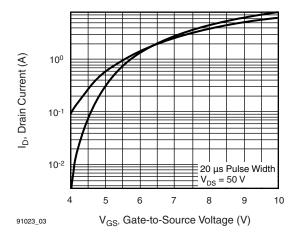


Fig. 3 - Typical Transfer Characteristics

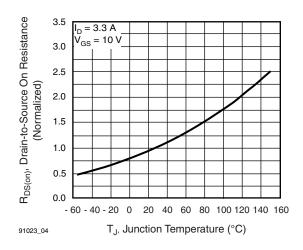


Fig. 4 - Normalized On-Resistance vs. Temperature

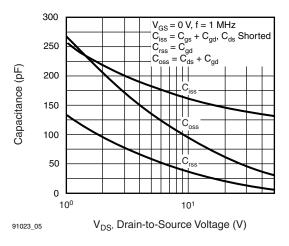


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

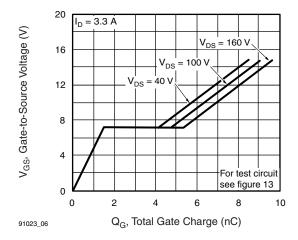


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



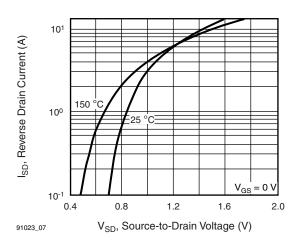


Fig. 7 - Typical Source-Drain Diode Forward Voltage

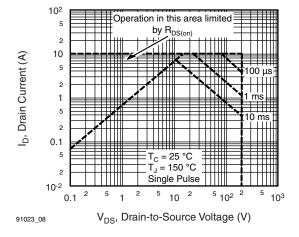


Fig. 8 - Maximum Safe Operating Area

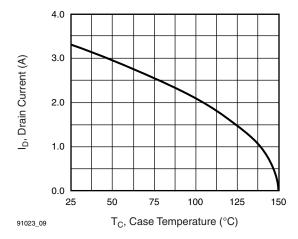


Fig. 9 - Maximum Drain Current vs. Case Temperature

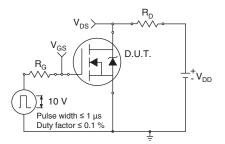


Fig. 10a - Switching Time Test Circuit

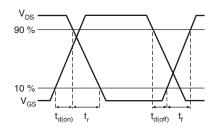


Fig. 10b - Switching Time Waveforms



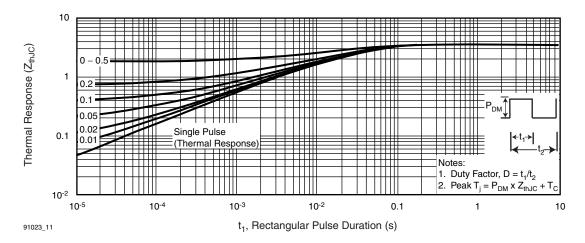


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

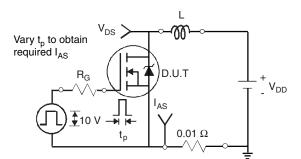


Fig. 12a - Unclamped Inductive Test Circuit

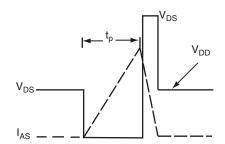


Fig. 12b - Unclamped Inductive Waveforms

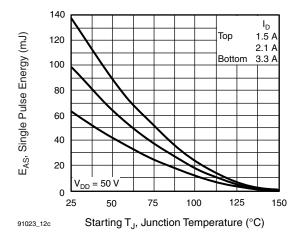


Fig. 12c - Maximum Avalanche Energy vs. Drain Current



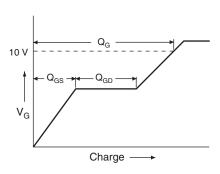


Fig. 13a - Basic Gate Charge Waveform

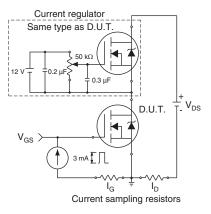
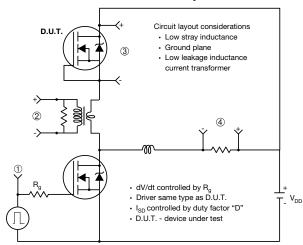


Fig. 13b - Gate Charge Test Circuit

#### Peak Diode Recovery dV/dt Test Circuit



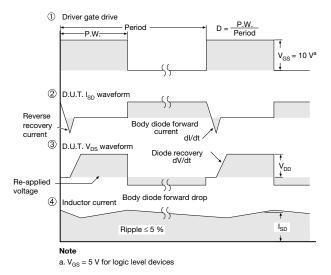


Fig. 14 - For N-Channel

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## TO-220-1



DIM.	MILLIM	METERS	INC	HES
	MIN.	MAX.	MIN.	MAX.
Α	4.24	4.65	0.167	0.183
b	0.69	1.02	0.027	0.040
b(1)	1.14	1.78	0.045	0.070
С	0.36	0.61	0.014	0.024
D	14.33	15.85	0.564	0.624
Е	9.96	10.52	0.392	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.10	6.71	0.240	0.264
J(1)	2.41	2.92	0.095	0.115
L	13.36	14.40	0.526	0.567
L(1)	3.33	4.04	0.131	0.159
ØP	3.53	3.94	0.139	0.155
Q	2.54	3.00	0.100	0.118

### Note

DWG: 6031

•  $M^* = 0.052$  inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



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